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## **Supporting Information for**

## **Giant piezoelectricity and ferroelectricity in two-dimensional ThOTe monolayer**

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**Figure S1** Phonon spectrum of ThOTe along the high symmetric points in BZ.



**Figure S2** Schematic diagram of ThOTe monolayer exfoliation process.

We calculated the bulk modulus and shear modulus using the following formulate,

$$
K^{V} = \frac{C_{11} + C_{22} + 2C_{12}}{4},
$$
  
\n
$$
G^{V} = \frac{C_{11} + C_{22} - 2C_{12} + 4C_{66}}{8},
$$
  
\n
$$
K^{R} = \frac{1}{S_{11} + S_{22} + 2S_{12}},
$$
  
\n
$$
G^{R} = \frac{2}{S_{11} + S_{22} - 2S_{12} + S_{66}},
$$
  
\n
$$
G^{H} = \frac{G_{V} + G_{R}}{2},
$$
  
\n
$$
K^{H} = \frac{B_{V} + B_{R}}{2}
$$

According to Hill, the arithmetic mean of the Voight and Reuss values can be used as an estimate of the mean shear modulus and mean bulk modulus, K and G and their ratios are shown in Table 1.



**Figure S3** Stress-strain curves in the ThOTe monolayer, the black dashed line corresponds to the magnitude of the strain when the stress is zero.



**Figure S4** The band structure evolution of ThOTe monolayer under different strains. The energy at the Fermi level is set to zero.



**Figure S5** The evolution of Density of states in ThOTe lattice under different strains. The energy at the Fermi level is set to zero.



**Figure S6** Energy in a monolayer ThOTe lattice at different strains in biaxial, respectively.



**Figure S7** The evolution of (a) band gap, (b) energy, (c) Fermi level and (d) the locations of the valence band maximum (VBM) and the conduction band minimum (CBM) under different strains.



**Figure S8** (a) and (b) represent the top and side views of ThOTe monolayer with 12% strain, respectively. The green, brown and red spheres represent the Th, Te and O atoms, respectively.  $(c) \sim$ (f) Electron density of states projected onto different atoms and atomic orbitals of Th, Te and O atoms.



**Figure S9** (a) and (b) represent the top and side views of ThOTe monolayer with 13% strain, respectively. The green, brown and red spheres represent the Th, Te and O atoms, respectively. (c)  $\sim$ (f) Electron density of states projected onto different atoms and atomic orbitals of Th, Te and O atoms.



**Figure S10** (a) and (b) represent the top and side views of ThOTe monolayer with 14% strain, respectively. The green, brown and red spheres represent the Th, Te and O atoms, respectively. (c)  $\sim$ (f) Electron density of states projected onto different atoms and atomic orbitals of Th, Te and O atoms.



**Figure S11** (a) and (b) represent the top and side views of ThOTe monolayer with 15% strain, respectively. The green, brown and red spheres represent the Th, Te and O atoms, respectively. (c)  $\sim$ (f) Electron density of states projected onto different atoms and atomic orbitals of Th, Te and O atoms.



**Figure S12** The photon energy absorption coefficients of ThOTe under different strains. (a) The x and y directions photon energy absorption coefficients of ThOTe under no strain, 14%, and 15% compressive strains. (b) The average photon energy absorption coefficients of ThOTe under 1%-5% tensile and compressive strains. (c) The average photon energy absorption coefficients of ThOTe under 6%-15% compressive strains. (d) The average photon energy absorption coefficients of ThOTe under 6%-15% tensile strains.



**Figure S13** d<sub>11</sub> of ThOTe at 14% strain and some other 2D materials by DFT calculation. [1-5]

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